



Form PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
M122-1518SERIAL NO.
09/653,156LIST OF ART CITED BY APPLICANT
(Use several sheets if necessary)

APPLICANT Vishnu K. Agarwal

FILING DATE
August 31, 2000GROUP
2813

U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
TN	AA	6,270,572	08/01	Kim et al	—	—	—
	AB						
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FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

DATE CONSIDERED

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ATTY. DOCKET NO.
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U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
JP	AA 6,281,142	06/1999	Basceri et al			
JP	AB 6,204,172	09/1998	Marsh			
JP	AC 5,432,732	07/1995	Obami			
JP	AD 6,242,299	06/2001	Hickert			
JP	AE 6,249,056	06/2001	Kwon			
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FOREIGN PATENT DOCUMENTS

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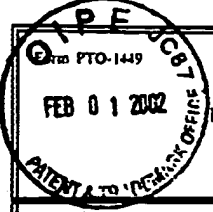

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER *JP*

DATE CONSIDERED 5/3/02

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		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-1518		SERIAL NO. 09/653.156		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Vishnu K. Agarwal				
				FILING DATE August 31, 2000		GROUP 2831		
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
47	AA	09/652,532		Dendelian (as amended 11/29/2001)			08/31/2000 KC 5/1/2002	
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FOREIGN PATENT DOCUMENTS								
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							Yes	No
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
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EXAMINER				DATE CONSIDERED				
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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

LIST OF ART CITED BY APPLICANT
(Indicate sheets if necessary)

ATTY. DOCKET NO.
MI22-1518

SERIAL NO.
09/633,156

APPLICANT Vishou K. Agarwal

FILING DATE
August 31, 2000

GROUP
2813

U.S. PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
U	AA 6,335,240	01-2002	Kim et al			
U	AB 5,156,606	12-2000	Michaelis			
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FOREIGN PATENT DOCUMENTS

Document Number	Date	Country	Class	Subclass	Translation	
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)





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EXAMINER *U/K*

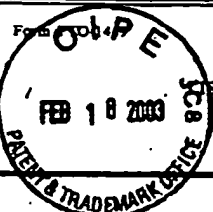
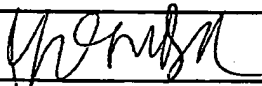
DATE CONSIDERED 9/13/02

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EV077329138

Form 1-100		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M12-1518		SERIAL NO. 09/633,156	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Vishnu K. Agarwal			
				FILING DATE August 31, 2000		GROUP 283	
U.S. PATENT DOCUMENTS							
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
	AA	6,180,481	01/2001	DeBoer et al	—	—	—
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FOREIGN PATENT DOCUMENTS							
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EXAMINER				DATE CONSIDERED			
				9/13/02			
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EV077329359

		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-1518		SERIAL NO. 09/653,156		
		ART OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Vishnu K. Agarwal		
		FILING DATE August 31, 2000		GROUP 2813				
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
OK	AA	2002/0064915A1	05/2002	Kitamura				
OK	AB	2001/0023110A1	09/2001	Fukuzumi et al				
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FOREIGN PATENT DOCUMENTS								
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							Yes	No
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
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<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>								

EV182661969

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO. MI22-1518		SERIAL NO. 09/653,156	
PRIOR ART CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT Vishnu K. Agarwal			
					FILING DATE August 31, 2000		GROUP 2831	
U.S. PATENT DOCUMENTS								
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate		
42	AA	5,641,984	06/1997	Aftergut et al	—	—	—	
42	AB	6,216,260	04/2001	Lee et al	—	—	—	
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
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EXAMINER			DATE CONSIDERED 5/3/02					
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